### **General Description**

The SJP30P043 uses advanced trench technology to provide excellent R<sub>DS(ON)</sub>, low gate charge and operation with gate voltages as low as -4.5V. This device is suitable for use as a wide variety of applications.

### **Features**

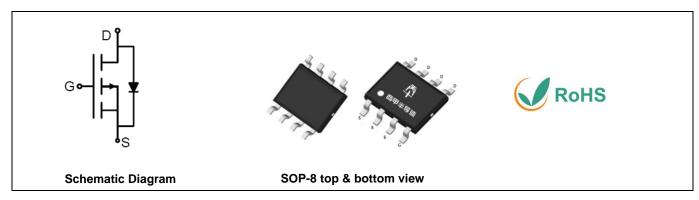
- Low Gate Charge
- 100% UIS Tested, 100% DVDS Tested
- High Power and current handing capability
- Lead free product is acquired

### **Application**

- PWM Applications
- Load Switch
- Power Management

### **Key Performance Parametes**

Parameter	Value	Unit
V <sub>DS</sub>	-30	V
R <sub>DS(ON)_TYP</sub>	5.3	mΩ
ID	-22	А
Q <sub>G</sub>	40.9	nC



### **Package Marking and Ordering Information**

Device/Ordering Code	Marking	Package	Packing	Reel Size	Tape width	Quantity
SJP30P043	SJP30P043	SOP-8	Tape	\	/	4000 Pcs

Table 1. Absolute Maximum Ratings (T<sub>A</sub>=25℃ unless otherwise noted)

Symbol	Parameter	Limit	Unit
V <sub>DS</sub>	Drain-Source Voltage (V <sub>GS</sub> =0V)	-30	V
V <sub>G</sub> S	Gate-Source Voltage (V <sub>DS</sub> =0V)	±20	V
1-	Drain Current-Continuous(T <sub>A</sub> =25℃)		А
I <sub>D</sub>	Drain Current-Continuous(T <sub>A</sub> =100℃)	-14	А
I <sub>DM</sub> (pluse)	Drain Current-Continuous@ Current-Pulsed (Note 1)	-88	А
D-	Maximum Power Dissipation(T <sub>A</sub> =25°C)	5.2	W
P <sub>D</sub>	Maximum Power Dissipation(T <sub>A</sub> =100℃)	2.1	W
Eas	Avalanche energy (Note 2)	380	mJ
TJ, TSTG	Operating Junction and Storage Temperature Range	-55 To 150	င

#### Table 2. Thermal Characteristic

Symbol	Parameter	Тур	Max	Unit
$R_{ heta JA}$	Thermal Resistance, Junction-to-Ambient		24	°C/W



Table 3. Electrical Characteristics ( $T_J=25^{\circ}C$  unless otherwise noted)

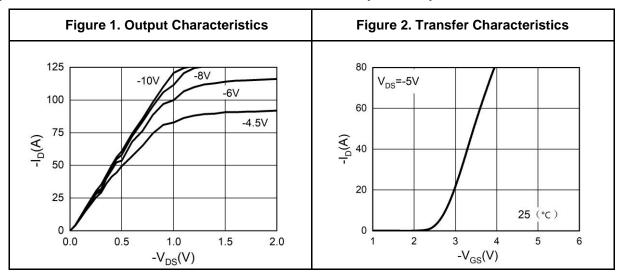
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
On/Off States						
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V I <sub>D</sub> =-250μA	-30			V
		V <sub>DS</sub> =-30V, V <sub>GS</sub> =0V T <sub>J</sub> =25 °C			-1	μΑ
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	Orain Current V <sub>DS</sub> =-30V, V <sub>GS</sub> =0V T <sub>J</sub> =125°C			-100	μΑ
Igss	Gate-Body Leakage Current	V <sub>GS</sub> =±20V, V <sub>DS</sub> =0V			±100	nA
V <sub>GS(th)</sub>	Gate Threshold Voltage	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =-250µA	-1		-2.2	V
<b>g</b> FS	Forward Transconductance	V <sub>DS</sub> =-5V, I <sub>D</sub> =-10A		45		S
R <sub>DS(ON)</sub>	Drain-Source On-State Resistance	V <sub>GS</sub> =-10V, I <sub>D</sub> =-20A T <sub>J</sub> =25 °C		5.3	6.6	mΩ
R <sub>DS(ON)</sub>	Drain-Source On-State Resistance	V <sub>GS</sub> =-4.5V, I <sub>D</sub> =-20A T <sub>J</sub> =25℃		7.1	9.4	mΩ
Dynamic Chara	octeristics				I	I
Ciss	Input Capacitance			4994		pF
$C_{oss}$	Output Capacitance	V <sub>DS</sub> =-15V,V <sub>GS</sub> =0V, f=1.0MHz		410		pF
Crss	Reverse Transfer Capacitance	1-1.000112		221		pF
Rg	Gate resistance	V <sub>GS</sub> =0V, V <sub>DS</sub> =0V, f=1.0MHz		8		Ω
Switching Para	meters					l
t <sub>d(on)</sub>	Turn-on Delay Time			13		nS
<b>t</b> r	Turn-on Rise Time	V <sub>GS</sub> =-10V, V <sub>DS</sub> =-30V,		115		nS
$t_{d(off)}$	Turn-Off Delay Time	$R_L$ =2Ω, $R_{GEN}$ =3Ω		78		nS
t <sub>f</sub>	Turn-Off Fall Time			86		nS
$Q_g$	Total Gate Charge			40.9		nC
Qgs	Gate-Source Charge	V <sub>GS</sub> =-10V, V <sub>DS</sub> =-15V, I <sub>D</sub> =-20A		9.9		nC
$Q_{gd}$	Gate-Drain Charge			14.3		nC
Source-Drain D	iode Characteristics	1		1	1	1
I <sub>SD</sub>	Source-Drain Current (Body Diode)				-22	А
V <sub>SD</sub>	Forward on Voltage (Note 3)	V <sub>GS</sub> =0V, I <sub>S</sub> =-10A			-1.2	V
t <sub>rr</sub>	Reverse Recovery Time	I <sub>F</sub> =-10A, dI/dt=-100A/μs		13		ns
Qrr	Reverse Recovery Charge	I <sub>F</sub> =-10A, dI/dt=-100A/μs		8		nC

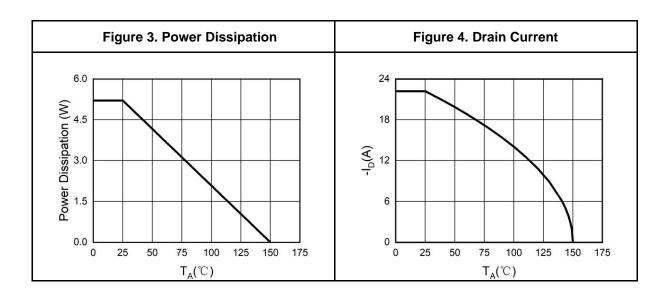
Notes 1.Repetitive Rating: Pulse width limited by maximum junction temperature.

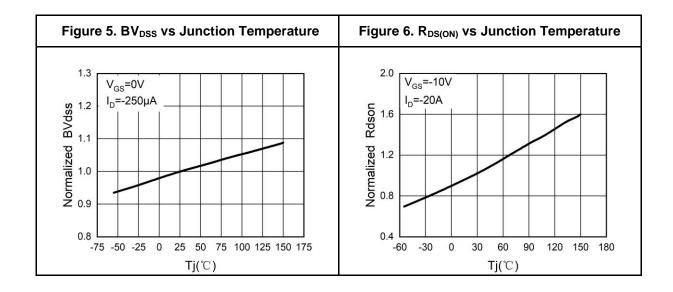
Notes 2.E<sub>AS</sub> condition:  $T_J=25^{\circ}C$ ,  $V_{DD}=-30V$ ,  $V_{G}=-10V$ ,  $Rg=25\Omega$ , L=0.5mH.

Notes 3.Repetitive Rating: Pulse width limited by maximum junction temperature.

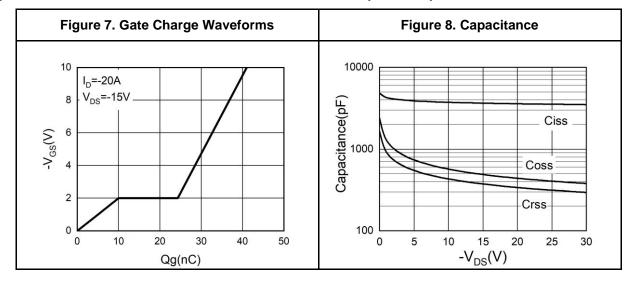
# **Typical Electrical And Thermal Characteristics (Curves)**

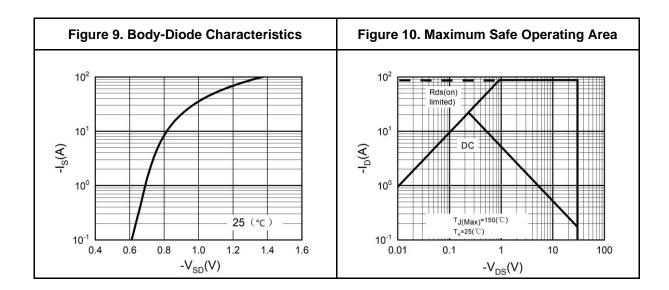






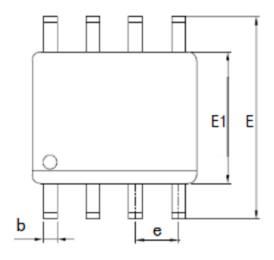
# **Typical Electrical And Thermal Characteristics (Curves)**

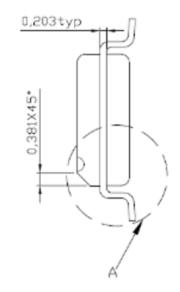


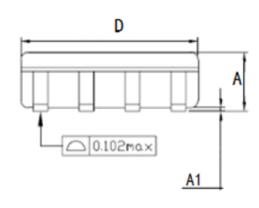


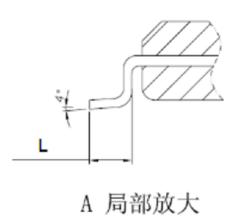


# **SOP-8 Package Information**









Symbol	Dimensions In Millimeters			
Symbol	Min.	Nom.	Max	
Α	1.35	1.55	1.75	
A1	0.1	0.15	0.2	
b	0.346	0.406	0.466	
D	4.8	4.89	4.98	
Е	5.75	6.00	6.25	
E1	3.81	3.90	3.99	
е		1.27TYP		
L	0.406	0.838	1.27	

#### Attention

This product described in this document can not be used in life support devices or systems, aircraft's control systems, and other applications whose failure can be reasonably expected to result in serious physical and/or material damage, apart from that when an application agreement is signed between customer and Wuxi Shangjia Semiconductor.

The performances and characteristics of this product in the independent testing state are displayed in this document. Wuxi Shangjia Semiconductor can't guarantee of the performances and characteristics of this described product that mounted in the customer's products or equipments as same as that in the independent testing state. So the customer should evaluate and test devices mounted in the customer's products or equipments.

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